

SUPPORTING TEST EXCELLENCE

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CLIC & KANAUE

















38 Years of Excellence In Test Systems



Presentation Agenda

- 1. Company Overview
- 2. HiLevel Products Overview
- 3. Product Specifications
- 5. Quality & Service
- 6. Demonstration
- 7. Summary & Questions



Company Overview

- Founded in 1979
 California Corporation
 Privately Owned
- HiLevel Worldwide Office Locations...



HiLevel Office Locations





Prime Resource: Customers

Over 100 Customers Worldwide

- U.S. Navy (FA/Characterization)
- Nasa (Production test USA)
- Freescale (Failure Analysis)
- Northrop Grumman (Production Test)
- Rockwell (Production/FA/Characterization)
- ISE/ChipX (Production USA)
- Progate (Production Taiwan)
- SMIC (Production China)



Our Mission

To Provide This Industry with a Sensible Solution:

The Most Cost-Effective Compact Failure
Analysis Tools & High-Precision Production
Tools Ever Made!



Our Products















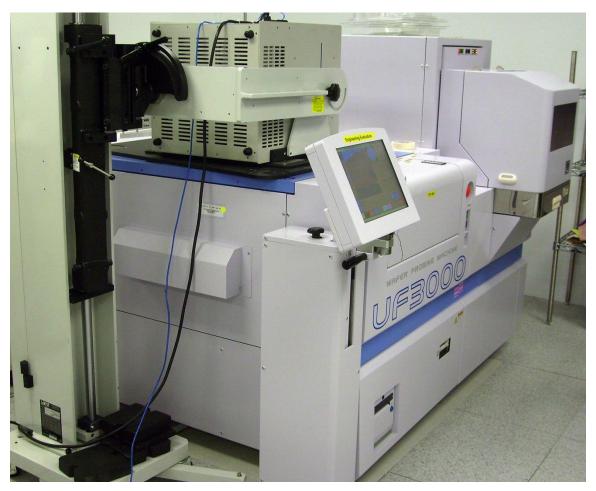








Direct Docking



HiLevel system direct docked to wafer sorter for MultiSite Testing





The Griffin III is for:

Production Testing

Failure Analysis

Design Verification

Device Characterization

Deepest Capture Memory

Up to 200/100MHz

500MHz Clocks

High Precision DC PMU

Digital & Mixed Signal, up to 512 pins







Powerful Tester Features

- Up to 16 sites for Multi-site testing
- Full "Next Cycle" Operation
 Data Valid for the full next cycle
- 64M vector memory and 64M capture memory
- Real-Time Failure counter
- Sophisticated Acquisition compression
- High-speed Acquisition Search
 Search 64M of capture in <3 sec
- Up to 128 scan chains and up to 8Gbit scan depth







Marketplace

Automotive Devices



Aerospace & Military

Consumer Products

Communications & Controllers



Pin Electronics Card

www.hilevel.com



32 independently controlled pins; format control, timing select; drivers, receivers, PMU/32, 1A DUT Power, programmable loads, 5mV resolution





Advantages

Fully optimized cost for higher ROI



Powerful Characterization Tools

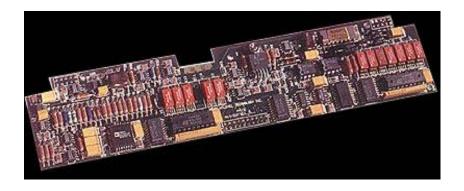
Quiet & Reliable
Design

Efficient MultiSite for true concurrent device testing



Multiple DC PMU

- One PMU per 32 pins
- +/- 150mA of Force current
- –8V to +8V at 5mV resolution







Differentiations

- True parallel test architecture
- Great repeatability & trustworthy test results
- Proven Quality & Reliability
- Focus on forward-compatibility
- User friendly intuitive design
- Modular design of MX2 option
- Zero-Footprint
- Portable, Quick, and Easy Setup Process







Innovative



Intuitive

In Step With Technology



ETS788 Test System

HILEVEL's ETS788 Test Station combines the most popular features of our ETS series testers with the modern technology and precision of our Griffin systems. This means that true APG memory test and single vector pattern generator commands are available with the latest high performance pin electronics and precision DC Parametrics.



In Step With Technology



ETS788 Test System

- Up to 16 sites for Multi-site testing
- True APG Memory Test
- Precision DC PMU
- Real-Time Failure counter
- Test rate up to 55/110MHz
- Dual Comparators per pin
- Sophisticated Acquisition compression
- High-speed Acquisition Search Search 64M of capture in <3 sec
- 4M vector memory and 64M capture memory







AC & DC Tester

The Griffin III Hybrid is for:

Production Testing

Failure Analysis

Design Verification

Device Characterization

Deepest Capture Memory

Up to 200/100MHz

500MHz Clocks

High Precision DC PMU

Digital & Mixed Signal

High pincount - up to 1152 pins

Lowest cost per pin









Powerful Tester Features

- Up to 4 sites for Multi-site testing (160 pins per site)
- Up to 128 channels per board
- Static vector on DC channels with I sink/source
- Four DC PMU units per DC128 board
- Multiple power supplies for modern devices
- 64M vector memory and 64M capture memory
- Real-Time Failure counter
- Sophisticated Acquisition compression
- High-speed Acquisition Search
 Search 64M of capture in <3 sec
- Up to 32 scan chains and up to 8Gbit scan depth





Marketplace

Automotive Devices



Aerospace & Military

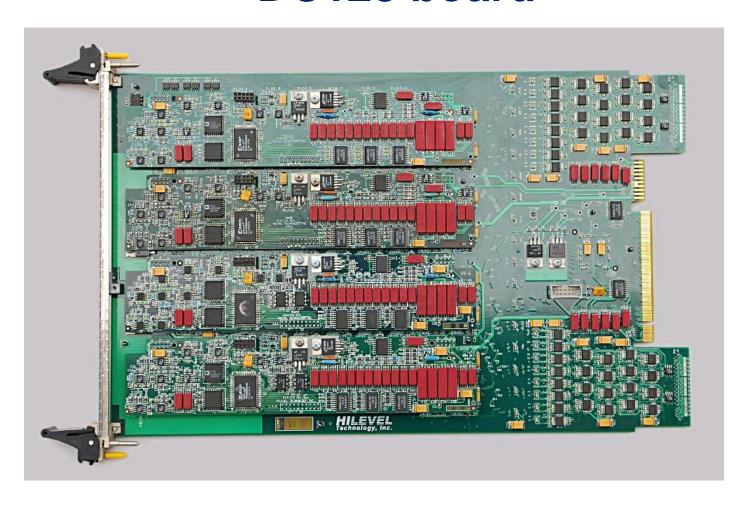


Communications & Controllers





DC128 board







High pincount in compact footprint

Advantages



Powerful
Characterization
Tools

Quiet & Reliable
Design

Multiple PMUs per board for true concurrent device testing



Summary of Benefits

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- ATE Power
- Fraction of ATE Cost
- "Zero-Footprint" yet high pin count
- Portable
- Quick, Easy Setup & Process
- Windows 7 or 10 Operating System
- Minimum Operator Training Required
- Relaxed Environmental Requirements





All New Analog Resources for Griffin Series Test Systems



Modular Design

Mix/Match analog resources:

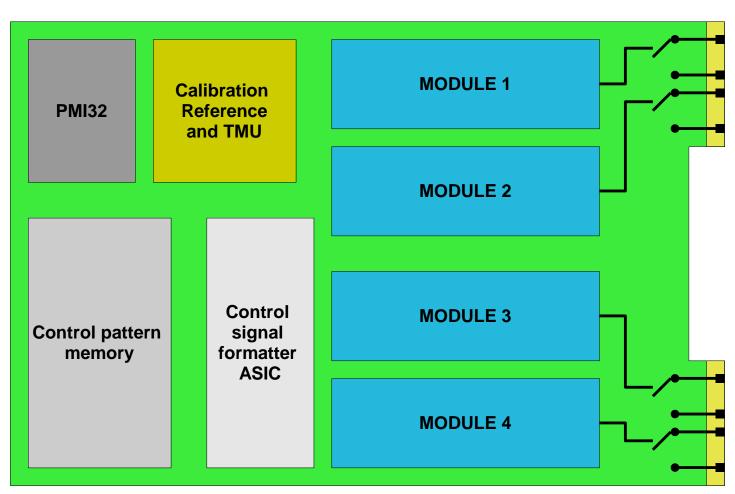
- 16 bit AWG
- 24 bit AWG
- 16 bit digitizer
- 24 bit digitizer
- High-voltage digital pins







Block Diagram





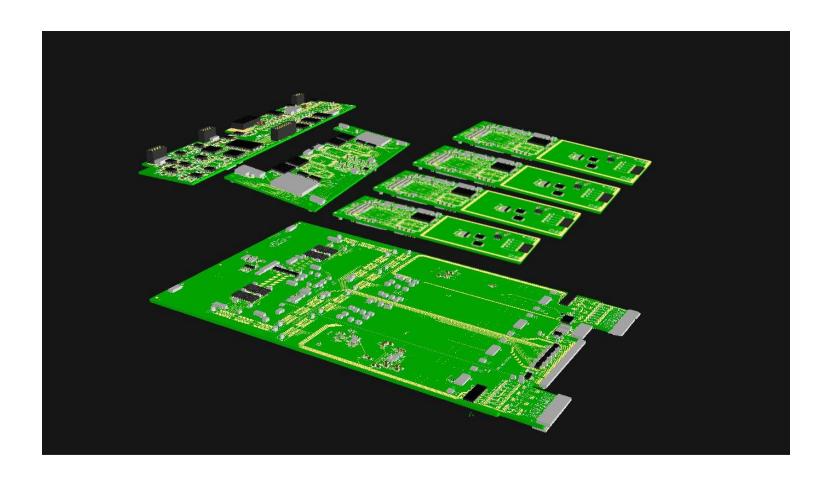
Configuration

- Install MX2 in PE slots of G3 or G3H
- Signals accessed via normal pin interface, no cables
- Mix and match any resources:
 - Three 24-bit AWG and one 24-bit Digitizer, or
 - Two 16-bit AWG, one 16-bit Digitizer and one 24-bit Digitizer, or
 - One 24-bit AWG, one Hi-V module and two 24-bit Digitizers, or
 - One of everything
 - Mix in any combination





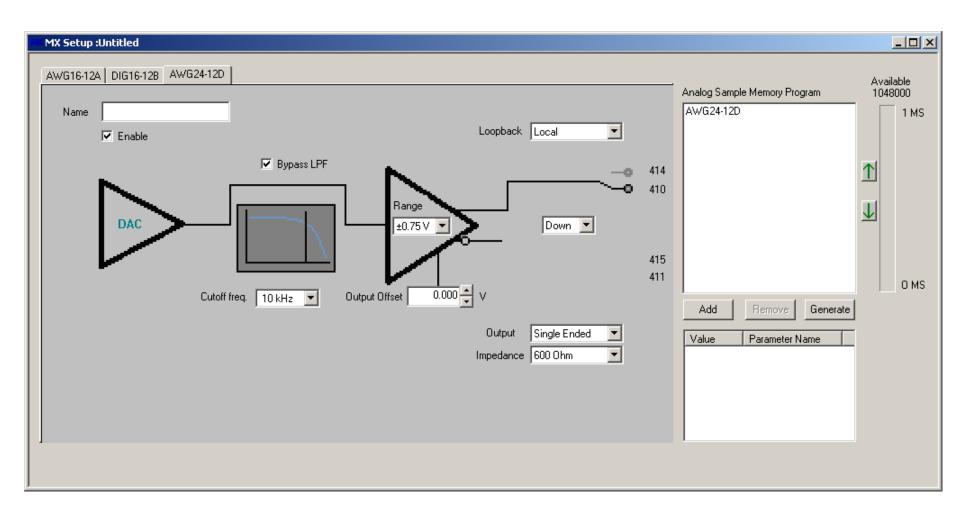
3D view







Easy GUI setup







Co-Optive DC Parametric Tester

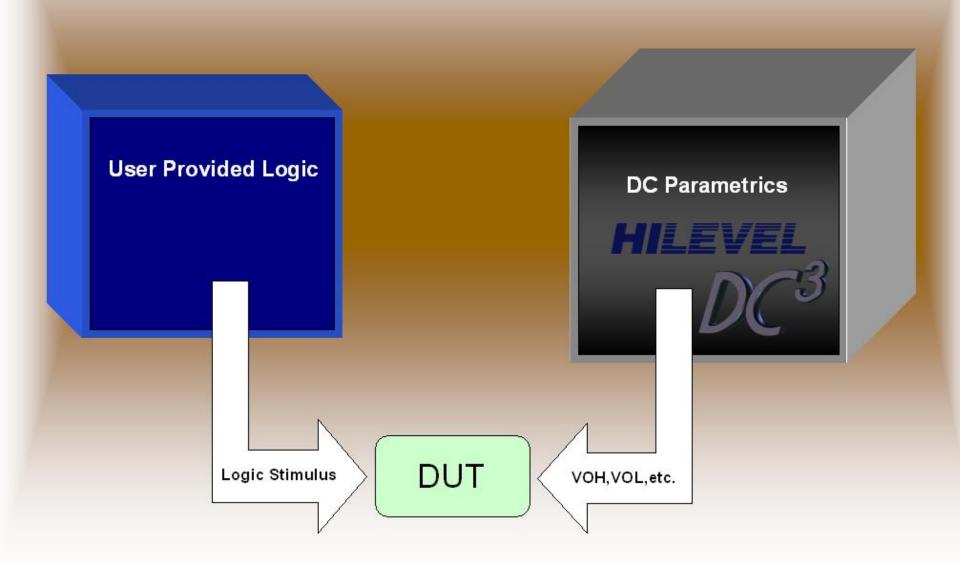
- DC and Continuity for Low-Cost Production Test
- Up to 2,048 pins
- Up to 64 sites
- High-Precision PMU
- Integrate with your own logic resources...

DC Parametric Test System with Curve Trace





DC³ Co-Optive Tester In partnership with YOUR logic







Low-Cost Curve Tracer for Failure Analysis

- Up to 2048 pins
- Expandable in 128-pin increments
- High Precision DC PMU
- Proven and modern technology and architecture
- Verify device authenticity



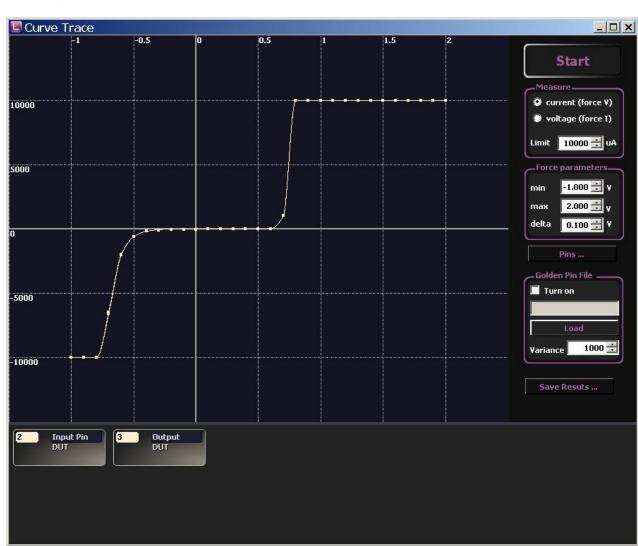






Curve Trace

- Easy setup
- User definable parameters
- View by current or voltage
- Windows 7platform

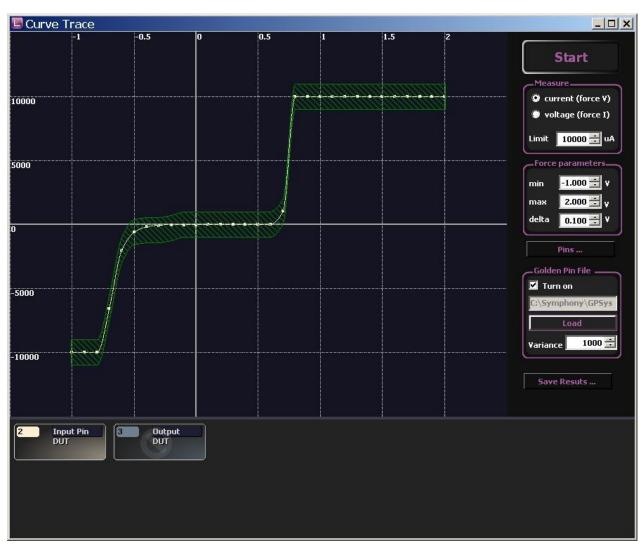






Curve Trace Golden Pin

User-defined variance is applied to a known-good device. Then the saved values can be loaded for comparison to more devices







DC-HiV

Curve Tracing with High Voltage

- ±120V up to 200mA
- ±30V up to 1A
- Maximum power 25W
- 8 outputs per board
- Mix with DC128 boards







Quality & Service

Typical MTBF of 16,000 hours for Pin Electronics cards

For example, a pin electronics card could operate continuously for up to three years without failing



TQM Indicators

www.hilevel.com

- ISO 9000 Certification
- Support of Motorola's Six Sigma Process
- U.S. Navy Federal Supply Class (FSC) ("All Green" Classification)
- Complete Northrop Grumman Supplier
 Q.C. Survey & Plant Inspection
- CSA certified (ETS)
- CE marking



Support and Maintenance

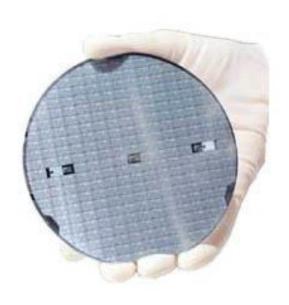
- One Year Warranty Parts & Labor
- Patented Service-friendly Design
- Individual access to System Boards
- Easy Access to Power Supplies and Fans



Summary of Benefits

- Excellent Customer Support since 1979
- Quick & Flexible "Small" Company
- A History of Compatibility
- Latest Technology
- Proven Quality
- Unmatched Price/Performance





Thank you!

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